

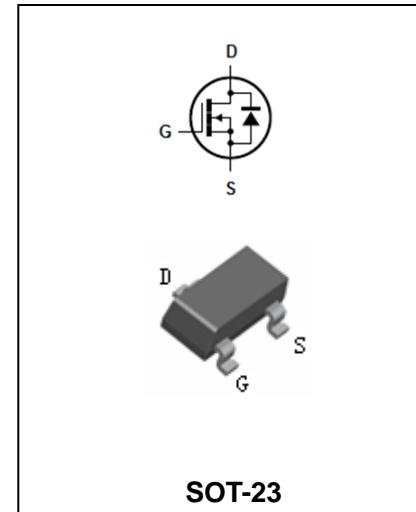


FEATURES

- N -channel
- ESD improved Capability.
- Depletion Mode
- Dv/dt rated

APPLICATIONS

- Line current interrupter in telephone sets
- Relay, high speed and line transformer drivers



ORDERING INFORMATION

Type No.	Marking	Package Code
F605	605	SOT-23

MAXIMUM RATING @ Ta=25°C unless otherwise specified

Symbol	Parameter	Value	Units
V _{DSX}	Drain-to-Source voltage	600	V
V _{GS}	Gate -Source voltage	± 20	V
I _D	Continuous Drain current Continuous Drain current T _c =70°C	0.030 0.024	A
I _{DM} ^{a1}	Pulsed Drain current	0.120	A
dv/dt ^{a2}	Peak Diode Recovery dv/dt	5.0	V/ns
P _D	Power Dissipation	0.5	W
V _{ESD(G-S)}	Gate source ESD(HBM-C=100pF,R=1.5kΩ)	300	V
T _J , T _{STG}	Operating Junction and StorageTemperature	150, -55 to +150	°C
T _L	Maximum Temperature for Soldering	300	°C



ELECTRICAL CHARACTERISTICS @ Ta=25°C unless otherwise specified

OFF Characteristics							
Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT	
Drain-Source Breakdown Voltage	V _{DSX}	V _{GS} =-5V, I _D =250μA	600	-	-	V	
Off-State Drain-to-Source voltage	I _{D(off)}	V _{DS} =600V, V _{GS} =-5V	-	-	0.1	uA	
Gate to Source Forward Leakage	I _{GSS(F)}	V _{GS} =20V	-	-	10	uA	
Gate to Source ReverseLeakage	I _{GSS (R)}	V _{GS} =-20V	-	-	-10	μA	

ON Characteristics							
Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT	
On-State Drain Current	I _{dss}	V _{DS} =25V, V _{GS} =0V	12	-	-	mA	
Drain-to-Source On-Resistance	R _{DS(ON)}	V _{GS} =0V, I _D =3mA	-	350	700	Ω	
		V _{GS} =10V, I _D =16mA	-	-	800		
Gate-to-Source Cut-off Voltage	V _{GS(OFF)}	V _{DS} =3V, I _D =8.0uA	-2.7	-2	-1.0	V	

Dynamic Characteristics							
Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT	
Forward Transconductance	g _{fs}	V _{DS} =50V, I _D =0.01A	0.008	0.017	-	S	
Input Capacitance	C _{iss}	V _{GS} =-5V, V _{DS} =25V,f=1.0MHz	-	50	-	pF	
Output Capacitance	C _{oss}		-	4.53	-		
Reserse Transfer Capacitance	C _{rss}		-	-1.08	-		

Resistive Switching Characteristics							
Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT	
Turn-on Delay Time	t _{d(ON)}	I _D =0.01A,V _{DD} =300V, V _{GS} =-5...7V, R _G =6.0 Ω	-	9.9	-	ns	
Rose Time	t _r		-	55.8	-		
Turn-Off Delay Time	t _{d(OFF)}		-	56.4	-		
Fall Time	t _f		-	136	-		



Total Gate Charge	Qg	ID=0.01A, VDD=400V, VGS=-5 to 5V	-	1.14		nC
Gate to Source Charge	Qgs		-	0.5		
Gate to Drain ("Miller") Charge	Qgd		-	0.37		

Source-Drain Diode Characteristics						
Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Continuous Source Current(Body Diode)	I _S	Ta=25°C	-	-	0.025	A
Maximum Pulsed Current(Body Diode))	I _{SM}		-	-	0.100	A
Diode Forward Voltage	V _{SD}	I _F =16mA, V _{GS} =-5V	-		1.2	V
Reserse Recovery Time	trr	I _F =0.01A, Tj=25°C, dI _F /dt=100A /us, V _R =300V	-	243	-	ns
Reserse Recovery Charge	Qrr		-	636	-	nC

Parameter	Symbol	TYP	UNIT
Junction-to-Ambient	R _{θJA}	250	°C/W

Gate –source Zener Diode						
Parameter	Symbol	Test conditions	Rating			UNIT
			MIN	TYP	MAX	
Gate-source breakdown voltage	V _{GSO}	IGS=±1mA(Open Drain)	20	-	-	V

The built-in-back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

a1: Repetitive rating; pulse width limited by maximum junction temperature

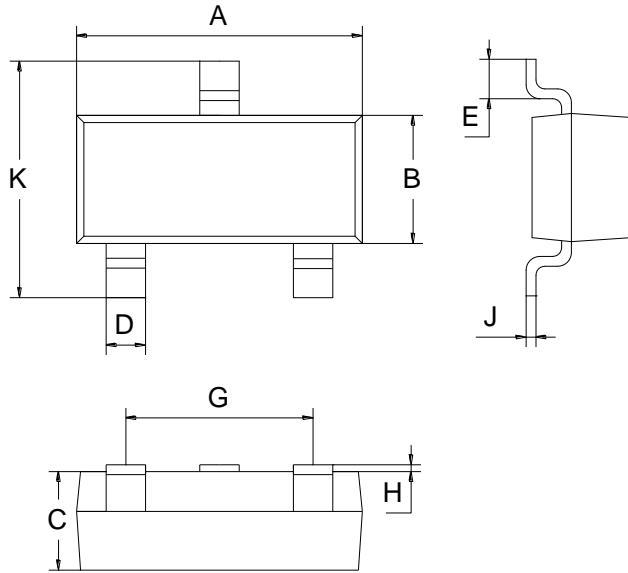
a2: IF=0.01A,di/dt≤100A/us,V_{DD}≤BV_{DS},Start Tj=25°C



PACKAGE OUTLINE

Plastic surface mounted package

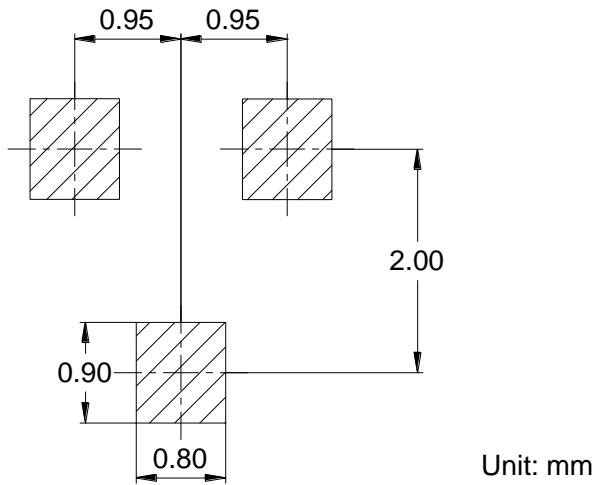
SOT-23



SOT-23		
Dim	Min	Max
A	2.70	3.10
B	1.10	1.50
C	0.90	1.10
D	0.30	0.50
E	0.35	0.48
G	1.80	2.00
H	0.02	0.10
J	0.05	0.15
K	2.20	2.60

All Dimensions in mm

SOLDERING FOOTPRINT



PACKAGE INFORMATION

Device	Package	Shipping
F605	SOT-23	3000pcs / Tape & Reel